

TEST REPORT

APPLICANT: WIKO

PRODUCT NAME: Smartphone

MODEL NAME : W_C200SN

BRAND NAME: Wiko

FCC ID : 2AM86WC200SN

STANDARD(S) : 47 CFR Part 15 Subpart C

TEST DATE : 2018-05-19 to 2018-05-25

ISSUE DATE : 2018-05-25

Tested by:

Wu Zhongwen (Test Engineer)

Approved by:

Andy Yeh (Technical Director)

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Change History					
Issue	Date	Reason for change			
1.0	2018-05-25	First edition			





1. Technical Information

Note: Provide by applicant.

1.1. Applicant and Manufacturer Information

Applicant:	WIKO	
Applicant Address:	1, rue Capitaine Dessemond 13007 - Marseille - France.	
Manufacturer:	Shenzhen Tinno Mobile Technology Corp.	
Manufacturer Address:	4/F, H-3 Building, OCT Eastern industrial Park, No.1 XiangShan	
	East Road.,Nan Shan District, Shenzhen, P.R. China	

1.2. Equipment Under Test (EUT) Description

Product Name:	Smartphone
Serial No:	(N/A, marked #1 by test site)
Hardware Version:	V1.1
Software Version:	W_C200SN-V02
Frequency Range:	13.553MHz-13.567MHz
Operating Frequency:	13.56MHz
Modulation Type:	ASK
Antenna Type:	Loop Antenna

Note 1: The EUT supports NFC function.

Note 2: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.





1.3. Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart C for the EUT FCC ID Certification:

Ī	No	Identity	Document Title
	1	47 CFR Part 15 (10-1-15 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Test Engineer	Result
1	15.203	Antenna Requirement	N/A	N/A	PASS
2	15.207	Conducted Emission	May 19, 2018	Wu Zhongwen	PASS
3	15.209	Radiated Emission	May 21, 2018	Wu Zhongwen	PASS
_	15.225(a)(b)(c)(d)		,,,		
4	15.225(e)	Frequency Tolerance	May 19, 2018	Wu Zhongwen	PASS
5	15.215(c)	20dB Bandwidth	May 25, 2018	Wu Zhongwen	PASS

Note: The tests were performed according to the method of measurements prescribed in ANSI C63.10-2013. The EUT has been tested under continuous operating condition.

1.4. Environmental Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 -60
Atmospheric Pressure (kPa):	86-106





2. 47 CFR Part 15C Requirements

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

Block67, BaoAn District, ShenZhen , GuangDong Province, P. R. China

FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,

2.1. Antenna requirement

2.1.1. Applicable Standard

According to FCC 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

2.1.2. Result:

The EUT has a permanently and irreplaceable attached antenna. Please refer to the EUT internal photos.

Result: Compliant





2.2. Conducted Emission

2.2.1. Test Requirement

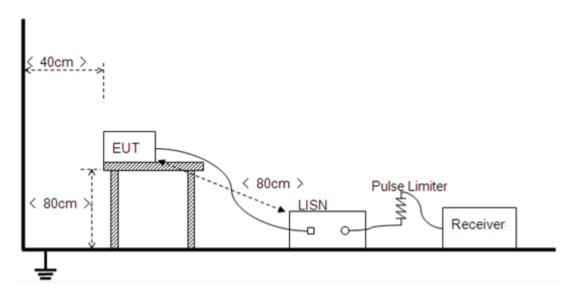
According to FCC section 15.207, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

Frequency rang	je Conducted Limit (dBµV)	Conducted Limit (dBµV)		
(MHz)	Quai-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

NOTE:

- (a) The lower limit shall apply at the band edges.
- (b) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

2.2.2. Test Setup



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.



2.2.3. Test Result

The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Refer to recorded points and plots below.

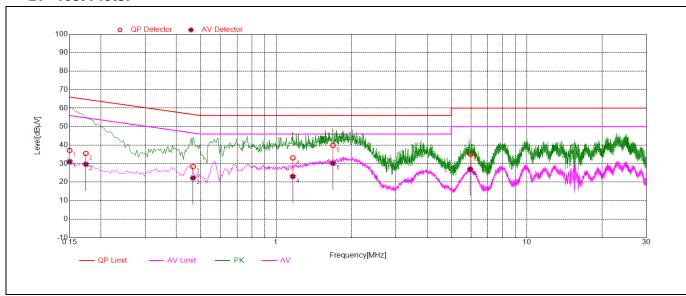
Note: Both of the test voltage AC 120V/60Hz and AC 230V/50Hz were considered and tested respectively, only the results of the worst case AC 120V/60Hz were recorded in this report.

A. Test setup:

The EUT configuration of the emission tests is <u>EUT + Link</u>.

Note: The test voltage is AC 120V/60Hz.

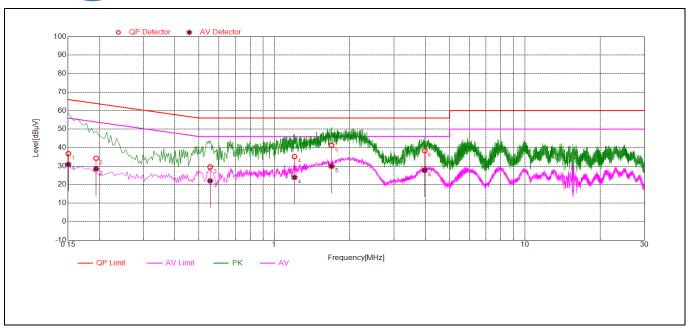
B. Test Plots:



(Plot A: L Phase)

NO.	Fre.	Emission L	.evel (dBµV)	Limit (dBμV)	Power-line	Verdict
	(MHz)	Quai-peak	Average	Quai-peak	Average		
1	0.15	37.15	31.10	66.00	56.00		PASS
2	0.17	35.52	29.67	64.77	54.77		PASS
3	0.47	28.44	22.27	56.59	46.59	Line	PASS
4	1.17	33.12	23.08	56.00	46.00	Line	PASS
5	1.69	39.86	30.17	56.00	46.00		PASS
6	5.95	35.13	27.09	60.00	50.00		PASS





(Plot B: N Phase)

NO.	Fre.	Emission L	.evel (dBµV)	Limit (dΒμV)	Power-line	Verdict
	(MHz)	Quai-peak	Average	Quai-peak	Average		
1	0.15	36.73	30.91	65.98	55.98		PASS
2	0.19	34.28	28.49	63.87	53.87		PASS
3	0.55	29.58	22.03	56.00	46.00	Noutral	PASS
4	1.20	35.18	23.92	56.00	46.00	Neutral	PASS
5	1.69	41.28	29.92	56.00	46.00		PASS
6	3.98	38.34	27.74	56.00	46.00		PASS



2.3. Radiated Emission

2.3.1. Test Requirement

Radiated Emission <30MHz (9 kHz-30MHz, E-field)

According to FCC section 15.225, for <30MHz, Radiated emissions were measured according to ANSIC63.4. The EUT was set to transmit at the highest output power. The EUT was set 30 meter away from the measuring antenna. The loop antenna was positioned 1 meter above the ground from the center of the loop. The measuring bandwidth was set to 10KHz. (Note: During testing the receive antenna was rotated about its axis to maximize the emission from the EUT)

There was no detected Restricted bands and Radiated Spurious emission below 30MHz. The 30m limit was converted to 3m Limit using square factor(x) as it was found by measurements as follows; $3 \text{ m Limit}(dBuV/m) = 20\log(X)+40\log(30/3)=20\log(15848)+40\log(30/3)=124dBuV$

Except as provided elsewhere in this Subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency range (MHz)	Field Stre	Field Strength@3m	
Frequency range (MHZ)	μV/m	dBμV/m	dBµV/m
Below 13.110	30	29.5	69.5
13.110 ~ 13.410	106	40.5	80.5
13.410 ~ 13.553	334	50.5	90.5
13.553 ~13.567	15.848	84	124
13.567 ~ 13.710	334	50.5	90.5
13.710 ~14.010	106	40.5	80.5
Above 14.010	30	29.5	69.5

NOTE: a) Field Strength ($dB\mu V/m$) = 20*log[Field Strength ($\mu V/m$)].

b) In the emission tables above, the tighter limit applies at the band edges.

Radiated Emission >30MHz (30MHz-1GHz, E-field)

According to FCC section 15.205, the field strength of radiated emissions from intentional radiators at a distance of 3 meters shall not exceed the following values:

	3					
Fraguenov rango (MHz)	Field S	trength				
Frequency range (MHz)	μV/m	dBμV/m				
30 - 88	100	40				
88 - 216	150	43.5				
216 - 960	200	46				
Above 960	500	54				

NOTE: a) Field Strength $(dB\mu V/m) = 20*log[Field Strength (\mu V/m)]$.

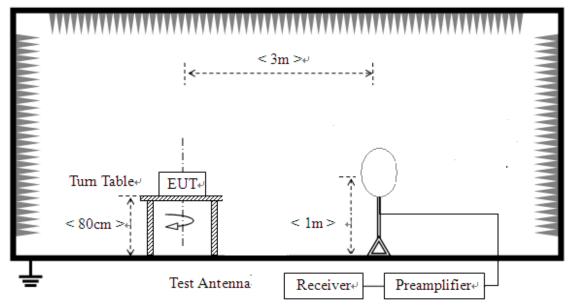
b) In the emission tables above, the tighter limit applies at the band edges.



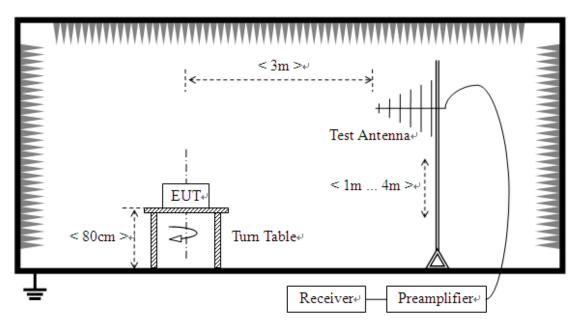


2.3.2. Test Setup

1) For radiated emissions below 30MHz



2) For radiated emissions from 30MHz to1GHz



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.



For the test Antenna:

In the frequency range of 9 kHz to 30MHz, magnetic field is measured with Loop Test Antenna. The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) was used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

2.3.3. Test Result

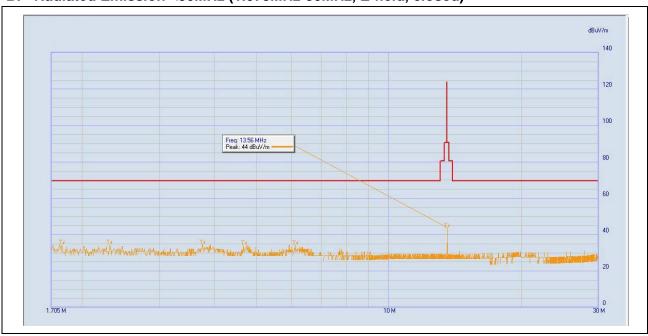
A. Radiated Emission <30MHz (1.075MHz-30MHz, E-field, opened)



NO.	Frequency (MHz)	Detector Type	Level at 3m (dB _μ V/m)	Limit at 3m (dBμV/m)
1	1.720	Quasi Peak	36.49	69.5
2	2.355	Quasi Peak	34.71	69.5
3	4.725	Quasi Peak	34.41	69.5
4	6.345	Quasi Peak	33.38	90.5
5	13.560	Quasi Peak	44.00	124.0
6	19.395	Quasi Peak	32.24	69.5



B. Radiated Emission <30MHz (1.075MHz-30MHz, E-field, closed)

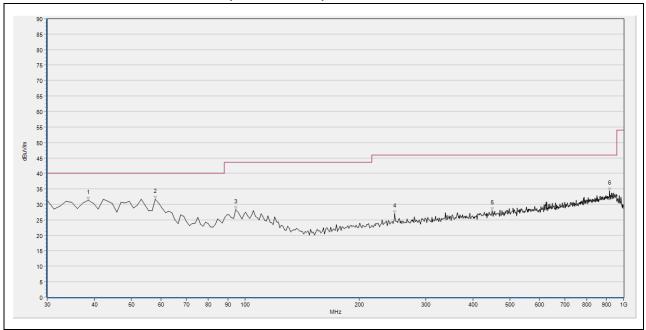


NO.	Frequency (MHz)	Detector Type	Level at 3m (dB _μ V/m)	Limit at 3m (dBµV/m)
1	1.800	Quasi Peak	34.57	69.5
2	2.310	Quasi Peak	34.70	69.5
3	3.765	Quasi Peak	34.56	69.5
4	4.675	Quasi Peak	34.42	69.5
5	6.120	Quasi Peak	34.50	69.5
6	13.560	Quasi Peak	44.00	124.0





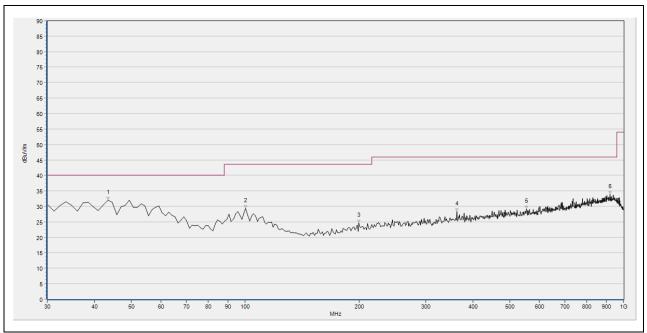
C. Radiated Emission >30MHz (30MHz-1GHz)



(30MHz - 1GHz, Test Antenna Horizontal)

No	Fre.	PK	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANIT	\/ordiot
No.	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	ANT	Verdict
1	38.498	31.39	N/A	N/A	N/A	40.00	N/A	Η	PASS
2	57.922	31.64	N/A	N/A	N/A	40.00	N/A	Η	PASS
3	94.343	28.24	N/A	N/A	N/A	43.50	N/A	Н	PASS
4	248.523	26.92	N/A	N/A	N/A	46.00	N/A	Н	PASS
5	450.050	27.98	N/A	N/A	N/A	46.00	N/A	Н	PASS
6	917.447	34.34	N/A	N/A	N/A	46.00	N/A	Н	PASS





(30MHz - 1GHz, Test Antenna Vertical)

No.	Fre.	PK	QP	AV	Limit-PK	Limit-QP	Limit-AV	ANT	Verdict
	MHz	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m	dBµV/m		
1	43.354	32.06	N/A	N/A	N/A	40.00	N/A	V	PASS
2	100.413	29.33	N/A	N/A	N/A	43.50	N/A	V	PASS
3	199.962	24.66	N/A	N/A	N/A	43.50	N/A	V	PASS
4	362.641	28.34	N/A	N/A	N/A	46.00	N/A	V	PASS
5	554.456	29.10	N/A	N/A	N/A	46.00	N/A	V	PASS
6	921.089	33.77	N/A	N/A	N/A	46.00	N/A	V	PASS

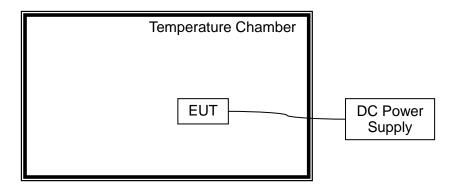


2.4. Frequency Tolerance

2.4.1. Test Requirement

According to FCC section 15.225, the devices operating in the 13.553~13.567 MHz shall maintain the carrier frequency within 0.01% of the operating frequency over the temperature variation of -20°C to +50°C using an environmental chamber. The primary supply voltage is varied from 85% to 115% of the voltage normally at the input to the device or at the power supply terminals if cables are not normally supplied.

2.4.2. Test Setup



The EUT, which is powered by the DC Power Supply directly, is located in the Temperature Chamber. The EUT was measured by transmitter mode continuously.



2.4.3. Test Result

Operating Frequency: 13,560,000 Hz

Deference Voltage: 3.8V Deviant Limit: ±0.01%

	To at	Canditions			
VOLTAGE (%)	Power (VDC)	Conditions Temperature (°C)	Frequency(Hz)	Deviation (%)	Verdict
100		-20	13,560,025	0.0001844	
100		-10	13,559,977	-0.0001696	
100		0	13,560,031	0.0002286	
100		+10	13,559,985	-0.0001106	
100	3.8	+20	13,560,025	0.0001844	
100		+25	13,560,026	0.0001917	DACC
100		+30	13,559,976	-0.0001770	PASS
100		+40	13,560,020	0.0001475	
100		+50	13,559,978	-0.0001622	
Battery End Point	3.5	+20	13,559,976	-0.0001770	
115	4.35	+20	13,559,982	-0.0001327	

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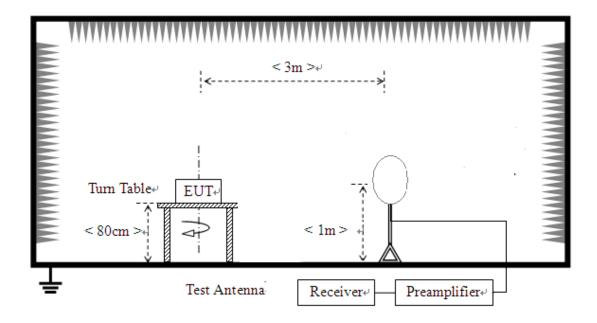


2.5.20dB Bandwidth

2.5.1. Standard Applicable

According to FCC section 15.215(c), the 20dB bandwidth should be contained within the frequency band designated in the rule section under which the EUT is operated, it was measured with a spectrum analyzer connected the EUT while the EUT is operating in transmission mode.

2.5.2. Test Setup



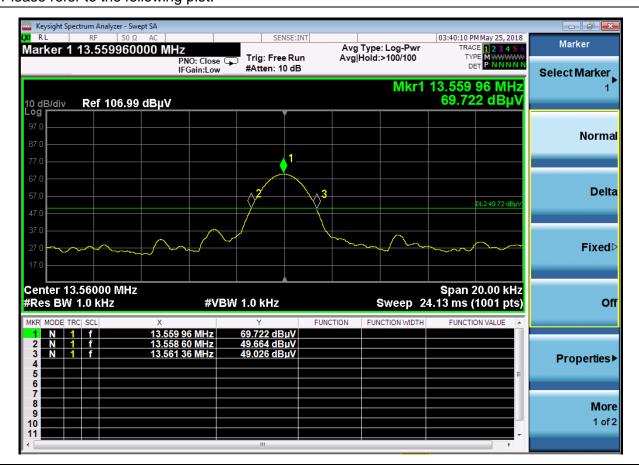




2.5.3. Test Result

	Meas	surement		Limit	
Centre Frequency	20dB Bandwidth (kHz)	Frequency Range (MHz)	20dB Bandwidth (kHz)	Frequency Range(MHz)	Verdict
13.56MHz	2.76	13.559 to 13.561	14	13.553 to 13.567	Pass

Please refer to the following plot:



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Annex A Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Radiated Emission:	±3.1dB
Conducted Emission:	±1.8dB
Bandwidth	±5%
Frequency Tolerance	±5%





Annex B Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.		
Department:	Morlab Laboratory		
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China		
Responsible Test Lab Manager:	Mr. Su Feng		
Telephone:	+86 755 36698555		
Facsimile:	+86 755 36698525		

2. Identification of the Responsible Testing Location

Namai	Shenzhen Morlab Communications Technology Co., Ltd.
Name:	Morlab Laboratory
	FL.3, Building A, FeiYang Science Park, No.8 LongChang
Address:	Road, Block 67, BaoAn District, ShenZhen, GuangDong
	Province, P. R. China

3. Facilities and Accreditations

All measurement facilities used to collect the measurement data are located at FL.3, Building A, FeiYang Science Park, Block 67, BaoAn District, Shenzhen, 518101 P. R. China. The test site is constructed in conformance with the requirements of ANSI C63.10-2013 and CISPR Publication 22; the FCC designation number is CN1192.





4. Test Equipments Utilized

4.1 Test Equipments

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Receiver	KEYSIGHT	N9038A	MY56400093	2017.07.13	2018.07.12
LISN	Schwarzbeck	NSLK 8127	812744	2018.05.08	2019.05.07
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	2018.05.08	2019.05.07
Coaxial Cable	Morlab	EMC01	CB01	N/A	N/A
Coaxial Cable	Morlab	EMC02	CB02	N/A	N/A
Anechoic Chamber	CRT	9m*6m*6m	N/A	2017.11.19	2020.11.18
Temperature Chamber	YinHe Experimental Equip.	HL4003T	N/A	2018.04.17	2019.04.16
Test Antenna – Bi-Log	Schwarzbeck	VULB 9163	9163-519	2018.05.08	2019.05.07
Test Antenna -Loop	Schwarzbeck	FMZB 1519	1519-022	2018.03.03	2019.03.02
DC Power Supply	Good Will Instrument Co.,Ltd.	N/A	N/A	2018.04.17	2019.04.16

4.2 Test Software Utilized

Model	Version Number	Producer
TS+ -[JS32-CE]	Version 2.5.0.0	Tonscend
MORLAB EMCR V1.2	Version 1.0	MORLAB